



Superworld Electronics (S) Pte Ltd

西普爾電子(新)私營有限公司

(Wholly owned by Superworld Holdings (S) Pte Ltd)

Reliability Test Standards

(1) Section A :

1. Molded Power Inductor
2. Ferrite Chip Beads and Inductor
3. LAN Transformer
4. SMD Power Inductor SPS2520 & SPS2016
5. Ceramic Wirewound Inductor (SCI Series)

➔ Table 1 (Automotive)

(2) Section B :

6. HF Transformer
7. Standard Power Inductor
8. Wireless Charging
9. Toroidal Choke Coil

➔ Table 2 (Automotive)

(3) For other products not in the list, we shall handle it on a case-by-case basis.



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Section A

1. Molded Power Inductor
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3. LAN Transformer
4. SPS2520 and SPS2016
5. Ceramic Wirewound Inductor (SCI Series)

➔ Table 1 (Automotive)





Table 1- Reliability Test Standard (Automotive)

Test	Failure Criteria	Test Condition
Pre and Post-Stress Electrical Test	a. Follow product data sheet	a. Sample Size: 77pcs b. Equipment: LCR Meter OHM Meter
High Temperature Exposure (Storage) (AEC-Q200)	a. Appearance: No damage. b. Impedance change: within $\pm 15\%$ of initial value c. Inductance change: within $\pm 10\%$ of initial value d. Q value : No out of spec e. RDC change: within $\pm 15\%$ of initial value and no out of spec	a. Pre-condition : Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 77pcs) b. Temperature: Refer datasheet c. Duration: 1000 hours min (measurement at 250 and 500 hrs) d. Place the parts at room temperature for 24 ± 2 hrs and then measured the electrical characteristic. e. Equipment: LCR Meter & OHM Meter & microscope
Temperature Cycling (AEC-Q200)	a. Appearance: No damage. b. Impedance change : within $\pm 15\%$ of initial value c. Inductance change: within $\pm 10\%$ of initial value d. Q value : No out of spec e. RDC change : within $\pm 15\%$ of initial value and no out of spec	a. Pre-condition : Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 77pcs) b. Highest Temperature & Lowest Temperature : Follow datasheet c. Maintain the predetermined temperature at least 30 mins. Rise to highest temperature within 1 min and maintain for at least 30 mins. Drop to lowest temperature within 1 min. Cycle, 1000 times. d. Place the parts at room temperature for 24 ± 2 hrs and then measured the electrical characteristic. e. Equipment: LCR Meter & OHM Meter & microscope



Table 1- Reliability Test Standard (Automotive) – Cont'd

Test	Failure Criteria	Test Condition
Destructive Physical Analysis	NA	NA
Biased Humidity (AEC-Q200)	<ul style="list-style-type: none">a. Appearance: No damage.b. Impedance change : within±15% of initial valuec. Inductance change: within±10% of initial valued. Q value : No out of spece. RDC change: within ±15% of initial value and no out of spec	<ul style="list-style-type: none">a. Pre-condition : Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 77pcs)b. Humidity : 85±3% R.Hc. Temperature : 85±2 °Cd. Duration: 1000 hours mine. Place the parts at room temperature for 24±2 hrs and then measured the electrical characteristic.f. Equipment: LCR Meter & OHM Meter & microscope
Operational Life (High temperature loading) (AEC-Q200)	<ul style="list-style-type: none">a. Appearance: No damage.b. Impedance change : within±15% of initial valuec. Inductance change: within±10% of initial valued. Q value : No out of spece. RDC change : within ±15% of initial value and no out of spec	<ul style="list-style-type: none">a. Pre-condition: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 77pcs)b. Temperature: Refer datasheetc. Duration: 1000hrs min. with 100% rated current.d. Place the parts at room temperature for 24±2 hrs and then measured the electrical characteristic.e. Equipment: LCR Meter & OHM Meter & microscope
Appearance	<ul style="list-style-type: none">a. Appearance: No damage.	<ul style="list-style-type: none">a. Inspect outer appearance, body marking and workmanship without electrical test.b. Equipment: Microscope



Table 1- Reliability Test Standard (Automotive) – Cont'd

Test	Failure Criteria	Test Condition															
Dimension	a. Follow Dimension Spec in datasheet	a. Refer datasheet b. Sample Size: 30pcs c. Equipment: Caliper															
Terminal Strength	a. Appearance: No damage.	a. Apply 910g pull force for 5~10 secs to the pin terminal. b. Sample Size: 30pcs c. Equipment: Microscope															
Resistance to Solvents	a. Appearance: No damage.	a. Add aqueous wash chemical - OKEM to clean or equivalent. b. Sample Size: 5pcs c. Equipment: Microscope															
Mechanical Shock	a. Appearance: No damage. b. Impedance change: within±15% of initial value c. Inductance change: within±10% of initial value d. Q value: No out of spec e. RDC change: within ±15% of initial value and no out of spec.	a. Pre-condition: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 30pcs) <table border="1" data-bbox="970 1133 1506 1223"> <thead> <tr> <th>Type</th> <th>Peak value (g's)</th> <th>Normal duration (D) (ms)</th> <th>Waveform</th> <th>Velocity change (Vi)ft/sec</th> </tr> </thead> <tbody> <tr> <td>SMD</td> <td>100</td> <td>6</td> <td>Half-sine</td> <td>12.3</td> </tr> <tr> <td>Lead</td> <td>100</td> <td>6</td> <td>Half-sine</td> <td>12.3</td> </tr> </tbody> </table> b. Equipment: LCR Meter & OHM Meter & microscope	Type	Peak value (g's)	Normal duration (D) (ms)	Waveform	Velocity change (Vi)ft/sec	SMD	100	6	Half-sine	12.3	Lead	100	6	Half-sine	12.3
Type	Peak value (g's)	Normal duration (D) (ms)	Waveform	Velocity change (Vi)ft/sec													
SMD	100	6	Half-sine	12.3													
Lead	100	6	Half-sine	12.3													
Vibration	a. Appearance: No damage. b. Impedance change: within±15% of initial value c. Inductance change: within±10% of initial value d. Q value: No out of spec e. RDC change: within ±15% of initial value and no out of spec	a. Pre-condition: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 30pcs) b. Equipment: Vibration Checker, LCR Meter & OHM Meter & Microscope c. Total Amplitude:5g d. Oscillation Frequency: 10HZ~2KHZ~10Hz for 20 minutes. e. Testing Duration: 12 hours (20 minutes, 12 cycles each of 3 orientations)															



Table 1- Reliability Test Standard (Automotive) – Cont'd

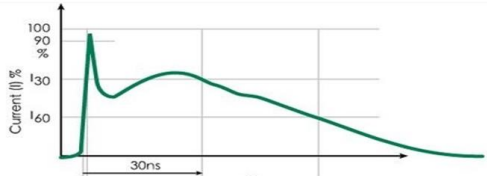
Test	Failure Criteria	Test Condition								
Resistance to Soldering Heat	a. Appearance: No damage. b. Impedance change: within±15% of initial value c. Inductance change: within±10% of initial value d. Q value: No out of spec e. RDC change: within ±15% of initial value and no out of spec	a. Sample Size: 30pcs <table border="1" data-bbox="951 465 1538 539"> <thead> <tr> <th>Soldering Temperature(°C)</th> <th>Time(s)</th> <th>Temperature ramp/immersion and emersion rate</th> <th>Number of heat cycle</th> </tr> </thead> <tbody> <tr> <td>260 ±5</td> <td>10 ±1</td> <td>25mm/s ±6 mm/s</td> <td>1</td> </tr> </tbody> </table> b. Equipment: LCR Meter & OHM Meter & 50X CCD	Soldering Temperature(°C)	Time(s)	Temperature ramp/immersion and emersion rate	Number of heat cycle	260 ±5	10 ±1	25mm/s ±6 mm/s	1
Soldering Temperature(°C)	Time(s)	Temperature ramp/immersion and emersion rate	Number of heat cycle							
260 ±5	10 ±1	25mm/s ±6 mm/s	1							
Thermal shock (AEC-Q200)	a. Appearance: No damage. b. Impedance change: within±15% of initial value c. Inductance change: within±10% of initial value d. Q value: No out of spec e. RDC change: within ±15% of initial value and no out of spec	a. Pre-condition: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 30pcs) b. Highest Temperature & Lowest Temperature : Follow datasheet c. Maintain the low temperature for 15±1 mins. When the temperature hit the predetermined temperature, Rise to highest temperature within 20 secs for 15±1 mins. Number of cycles is 300. d. Place the parts at room temperature for 24±2 hrs and then measured the electrical characteristic. e. Equipment: Thermal shock tester, LCR Meter & OHM Meter								
ESD	a. Appearance: No damage.	a. Sample Size: 15pcs b. Equipment: microscope 								

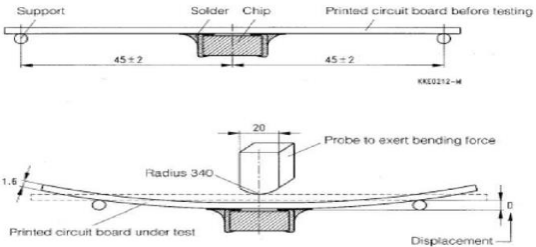
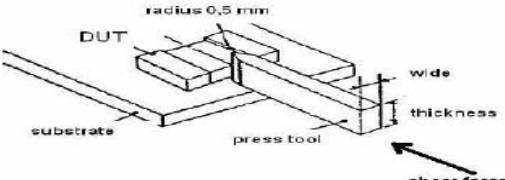


Table 1- Reliability Test Standard (Automotive) – Cont'd

Test	Failure Criteria	Test Condition
Solderability	a. Appearance: More than 95% of the terminal electrode shall be covered with solder.	a. Sample Size: 15pcs b. Method B: 1. Baking: 155±5°C 4 Hours; 2. Soldering Temp: 235±5°C; 3. Soldering Time: 5 + 0/-0.5S; 4. Depth: completely cover the termination. c. Method D: 1. Steam aging: (93±3°C, 8 hours±15 min) 2. Soldering Temp: 260±5°C 3. Soldering Time: 30 + 0/-0.5 sec 4. Depth: completely cover the termination. Remarks: • Perform soldering until solder is formed on the terminations. • All terminations shall have visible solder residues. d. Equipment: Solder Pot & 50X CCD
Electrical Characteristics	a. Follow datasheet	a. Sample Size: 30pcs / lot b. Lots: 3 lots c. Equipment: LCR Meter & OHM Meter d. Record min, max, mean and standard deviation of electrical characteristics.
Flammability	a. Not required electrical test	a. Sample Size: 30pcs b. V-0 or V-1 are acceptable.



Table 1- Reliability Test Standard (Automotive) – Cont'd

Test	Failure Criteria	Test Condition
Board Flex	a. Appearance: No damage.	<p>a. Pre-condition: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 30pcs)</p> <p>b. Place the component (facing down) on the 100mm X 40mm board.</p> <p>c. Apply force to bend the board until D, 2mm min for 60 + 5 sec for 1 time.</p>  <p>d. Equipment: Microscope</p>
Terminal Strength (SMD)	a. Appearance: No damage.	<p>a. Pre-condition: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profile) (Sample Size: 30pcs)</p> <p>b. Apply 17.7 N (1.8 Kg) force gradually to the side of PCBA device for 60 +1 secs without apply shock to the component.</p>  <p>c. Equipment: Microscope</p>



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➔ Table 2 (Automotive)

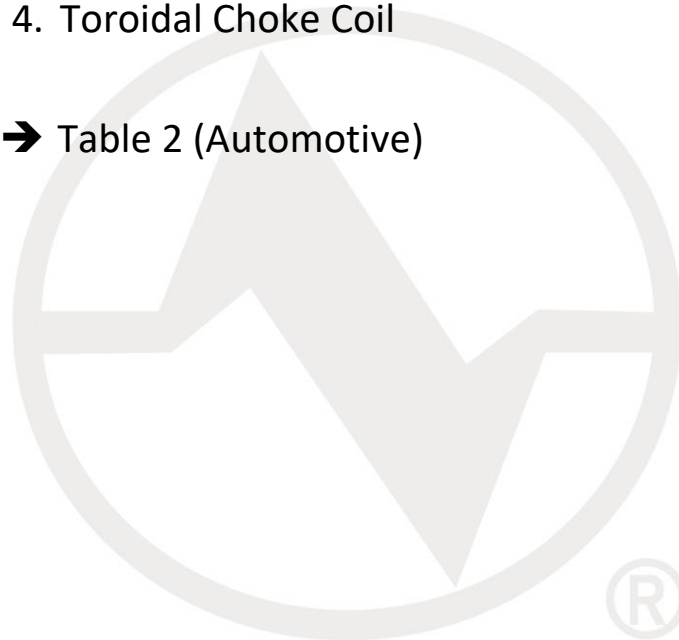




Table 2- Reliability Test Standard (Automotive)

Test	Failure Criteria	Test Condition
High Temperature Exposure (Storage) (AEC-Q200)	a. MIL-STD-202 b. Method 108	a. Sample Size: 77pcs b. 1000 hrs. at rated operating temperature (e.g. part can be stored for 1000 hrs. @ 125°C, 105°C and 85°C.) c. Measured the electrical characteristic within 24±2 hrs after the test. *The actual test temperature follow customer requirements.
Temperature Cycling (AEC-Q200)	a. JESD22 Method b. JA-104	a. Sample Size: 77pcs b. Method: 1. -40 ± 2°C 30mins Min. 2. Transition time, 1min Max. 3. 125°C ± 2°C 30min Min. 4. Transition time, 1min Max. 5. Number of cycles: 1000
Biased Humidity (AEC-Q200)	a. MIL-STD-202 b. Method 103	a. Sample Size: 77pcs b. Humidity: 85 ± 3% RH c. Temperature: 85°C± 2°C d. Duration: 1000 hours
Appearance	a. MIL-STD-883 b. Method 2009	a. Sample Size: All submitted qty b. Inspect equipment, marking and workmanship c. not required electrical test
Dimension	a. JESD22 Method b. JB-100	a. Sample Size: All submitted qty b. Verify dimension c. not required electrical test of user and manufacturer.
Resistance to Solvents (AEC-Q200)	a. MIL-STD-202 b. Method 215	a. Sample Size: 5pcs b. Immerse in solvent, 3+0.5/-0 mins at 25±5°C. Brush 10 times by using toothbrush, repeat 3 times and rinse with water, dry by air blow.



Table 2- Reliability Test Standard (Automotive) – Cont'd

Test	Failure Criteria	Test Condition
Vibration Test (Component)	a. MIL-STD-202 b. Method 204	a. Sample Size: 30pcs b. Frequency range: 10 Hz - 2000 Hz -10 Hz for 20 minutes (1 cycle) c. 12 cycles for each orientation and a total of 12 hours d. Maximum acceleration (m / s ²): 5G, No-load Amplitude range: 1.52mm
Solderability	a. Appearance: More than 95% of the terminal electrode shall be covered with solder. (J-STD-002)	a. Sample Size: 15pcs b. Method: 1. Steam aging: (93±3°C, 16 hours±30 min) 2. Soldering Temp: 245±5°C 3. Soldering Time: 5 + 0/-0.5 sec
Electrical Characteristics	a. Follow datasheet	a. Sample Size: All submitted qty b. Record min, max, mean and standard deviation of electrical characteristics as per lot and sampling size requirements.
Pre & Post Stress Electrical Test	a. Follow datasheet	a. Test is performed at 25±5°C except applicable stress reference and the additional requirements
Drop Test (Packaging)	a. ASTM D5276 – 98	a. Use drop tester to drop the part in carton box from 1m height. b. Test sequence: Corner, three sides, six surfaces.
Salt spray test	a. GB2423.17-2008	a. Salt water (5% NaCl) solution b. PH value 6.6-7.2 c. Temperature 35±3°C d. Humidity: 95-98% RH e. Duration: 24Hrs



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➔ Please consult the Engineering/Quality Managerial teams for applicable reliability test requirements.

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